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- *EPIC*<sup>™</sup> (Enhanced-Performance Implanted CMOS) Submicron Process
- Typical V<sub>OLP</sub> (Output Ground Bounce)
  < 0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot)
  > 2 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Inputs Accept Voltages to 5.5 V
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, Ceramic Flat (W) Packages, Chip Carriers (FK), and DIPs (J)

### description

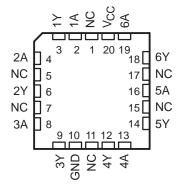
The SN54LVC14A hex Schmitt-trigger inverter is designed for 2.7-V to 3.6-V V<sub>CC</sub> operation and the SN74LVC14A hex Schmitt-trigger inverter is designed for 1.65-V to 3.6-V V<sub>CC</sub> operation.

The devices contain six independent inverters, and perform the Boolean function  $Y = \overline{A}$ .

SN54LVC14A J OR W PACKAGE
SN74LVC14A D, DB, OR PW PACKAGE
(TOP VIEW)

	•			
1A [ 1Y [ 2A [ 2Y [ 3A [ 3Y [ GND ]	2 3 4	υ	12 11	V <sub>CC</sub>   6A   6Y   5A   5Y   4A   4Y

SN54LVC14 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-V/5-V system environment.

The SN54LVC14A is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74LVC14A is characterized for operation from –40°C to 85°C.

FUNCTION TABLE (each inverter)							
INPUT A	OUTPUT Y						
Н	L						
L	Н						



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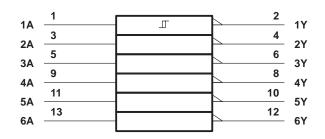
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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## logic symbol<sup>†</sup>



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, DB, J, PW, and W packages.

## logic diagram, each inverter (positive logic)



## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>‡</sup>

Supply voltage range, V <sub>CC</sub>		–0.5 V to 6.5 V
Input voltage range, V <sub>I</sub> (see Note 1)		–0.5 V to 6.5 V
Output voltage range, V <sub>O</sub> (see Notes 1 and 2)	-0.8	5 V to V <sub>CC</sub> + 0.5 V
Input clamp current, IIK (VI < 0)		–50 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)		–50 mA
Continuous output current, IO		±50 mA
Continuous current through V <sub>CC</sub> or GND		±100 mA
Package thermal impedance, $\theta_{JA}$ (see Note 3):	: D package	127°C/W
	DB package	158°C/W
	PW package	170°C/W
Storage temperature range, T <sub>stg</sub>		. –65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The value of  $\mathsf{V}_{CC}$  is provided in the recommended operating conditions table.

3. The package thermal impedance is calculated in accordance with JESD 51.



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## recommended operating conditions (see Note 4)

			SN54LVC14A		SN74LV0	C14A	LINUT
			MIN	MAX	MIN	MAX	UNIT
Vee	Supply voltogo	Operating	2	3.6	1.65	3.6	V
VCC	Supply voltage	Data retention only	1.5		1.5		V
VI	Input voltage		0	5.5	0	5.5	V
VO	Output voltage		0	Vcc	0	VCC	V
	High-level output current	V <sub>CC</sub> = 1.65 V				-4	mA
lau		$V_{CC} = 2.3 V$				-8	
ЮН		$V_{CC} = 2.7 V$		-12		-12	
		$V_{CC} = 3 V$		-24		-24	
		V <sub>CC</sub> = 1.65 V				4	
la.		$V_{CC} = 2.3 V$				8	mA
IOL	Low-level output current	$V_{CC} = 2.7 V$		12		12	
		$V_{CC} = 3 V$		24		24	
TA	Operating free-air temperature		-55	125	-40	85	°C

NOTE 4: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics	over	recommended	operating	free-air	temperature	range	(unless
otherwise noted)					-	•	

	TEST CONDITIONS		SN	54LVC14A	SN	74LVC14A	UNIT
PARAMETER	TEST CONDITIONS	Vcc	MIN	ΤΥΡ <sup>†</sup> ΜΑΧ	MIN	ΤΥΡ <sup>†</sup> ΜΑΧ	
V <sub>T+</sub>		2.7 V	0.8	2	0.8	2	
Positive-going		3 V	0.8	2	0.8	2	V
threshold		3.6 V	0.8	2	0.8	2	1
V <sub>T</sub> _		2.7 V	0.4	1.4	0.4	1.4	
Negative-going		3 V	0.6	1.5	0.6	1.5	V
threshold		3.6 V	0.8	1.8	0.8	1.8	1
ΔVT		2.7 V	0.3	1.1	0.3	1.1	
Hysteresis		3 V	0.3	1.2	0.3	1.2	V
$(V_{T+} - V_{T-})$		3.6 V	0.3	1.2	0.3	1.2	
	I <sub>OH</sub> = -100 μA	1.65 V to 3.6 V			V <sub>CC</sub> -0.	2	
		2.7 V to 3.6 V	V <sub>CC</sub> -0.	2			
	$I_{OH} = -4 \text{ mA}$	1.65 V			1.2		
VOH	$I_{OH} = -8 \text{ mA}$	2.3 V			1.7		V
	1au - 12 mA	2.7 V	2.2		2.2		
	I <sub>OH</sub> = -12 mA	3 V	2.4		2.4		
	I <sub>OH</sub> = -24 mA	3 V	2.2		2.2		1
	Let 100 ··· A	1.65 V to 3.6 V				0.2	
	l <sub>OL</sub> = 100 μA	2.7 V to 3.6 V		0.2			
Ve	I <sub>OL</sub> = 4 mA	1.65 V				0.45	v
VOL	I <sub>OL</sub> = 8 mA	2.3 V				0.7	
	I <sub>OL</sub> = 12 mA	2.7 V		0.4		0.4	
	I <sub>OL</sub> = 24 mA	3 V		0.55		0.55	
l	$V_{I} = 5.5 V \text{ or GND}$	3.6 V		±5		±5	μA
ICC	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	3.6 V		10		10	μA
ΔICC	One input at $V_{CC}$ – 0.6 V, Other inputs at $V_{CC}$ or GND	2.7 V to 3.6 V		500		500	μA
Ci	V <sub>I</sub> = V <sub>CC</sub> or GND	3.3 V		5		5	рF

<sup>†</sup> All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 2.7 V		$V_{CC} = 2.7 V$ $V_{CC} = 3.3 V$ $\pm 0.3 V$		UNIT
			MIN	MAX	MIN	MAX	
<sup>t</sup> pd	A	Y		7.5	1	6.4	ns



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# switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

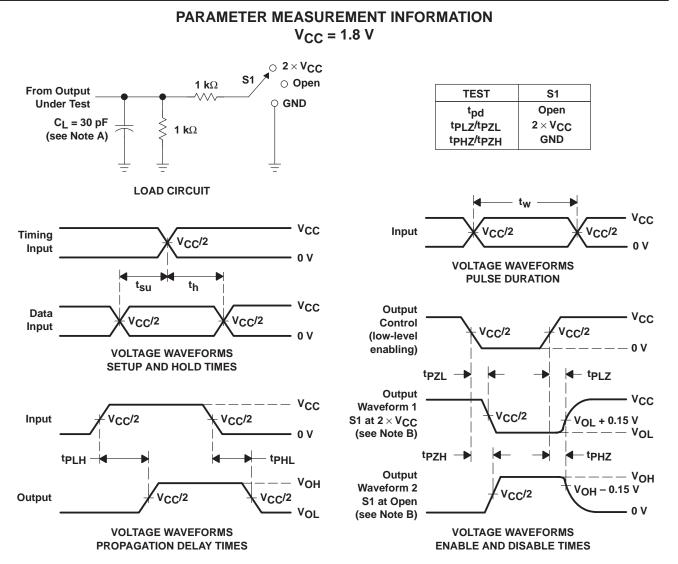
					SN74L	VC14A				
PARAMETER		TO (OUTPUT) V <sub>C</sub>	V <sub>CC</sub> = 1.8 V	V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT
			TYP	MIN	MAX	MIN	MAX	MIN	MAX	
<sup>t</sup> pd	A	Y	13.7	1	7.9		7.5	1	6.4	ns
<sup>t</sup> sk(o)									1	ns

## operating characteristics, $T_A = 25^{\circ}C$

Γ		PARAMETER	TEST	V <sub>CC</sub> = 1.8 V	V <sub>CC</sub> = 2.5 V	V <sub>CC</sub> = 3.3 V	UNIT	
		FARAMETER	CONDITIONS	TYP	TYP	TYP	UNIT	
	C <sub>pd</sub>	Power dissipation capacitance per inverter	f = 10 MHz	11	12	15	pF	



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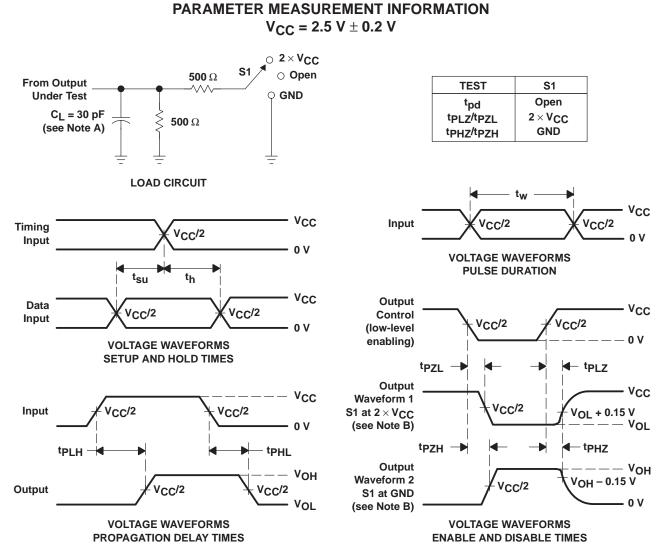
- NOTES: A. CL includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2 ns, t<sub>f</sub>  $\leq$  2 ns.

  - D. The outputs are measured one at a time with one transition per measurement.
  - E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - F. tpzL and tpzH are the same as ten.
  - G. tpl H and tpHI are the same as tpd.

### Figure 1. Load Circuit and Voltage Waveforms



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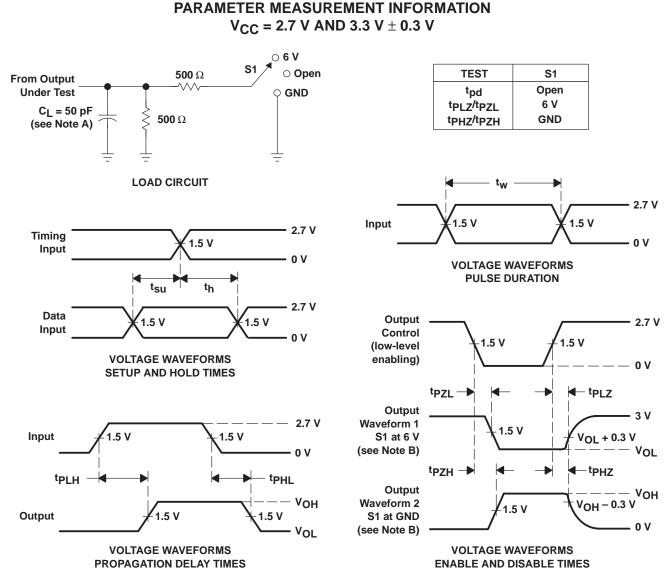
- NOTES: A. C<sub>I</sub> includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2 ns, t<sub>f</sub>  $\leq$  2 ns.
  - D. The outputs are measured one at a time with one transition per measurement.

  - E. tPLZ and tPHZ are the same as tdis.
  - F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
  - G. tpl H and tpHI are the same as tpd.

## Figure 2. Load Circuit and Voltage Waveforms



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NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2.5 ns. t<sub>f</sub>  $\leq$  2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

### Figure 3. Load Circuit and Voltage Waveforms



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